

Notice of References Cited	Application/Control No. 10/090,938	Applicant(s)/Patent Under Reexamination YOON ET AL.	
	Examiner Hiep Nguyen	Art Unit 2816	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,437,832	08-2002	Grabb et al.	348/614
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	C	US-6,505,032	01-2003	McCorkle et al.	455/41
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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